Direct correlation of crystal structure and optical properties in wurtzite/zinc-blende GaAs nanowire heterostructures

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(Dated: October 24, 2018)

A novel method for the direct correlation at the nanoscale of structural and optical properties of single GaAs nanowires is reported. Nanowires consisting of 100% wurtzite and nanowires presenting zinc-blende/wurtzite polytypism are investigated by photoluminescence spectroscopy and transmission electron microscopy. The photoluminescence of wurtzite GaAs is consistent with a band gap of 1.5 eV. In the polytypic nanowires, it is shown that the regions that are predominantly composed of either zinc-blende or wurtzite phase show photoluminescence emission close to the bulk GaAs band gap, while regions composed of a nonperiodic superlattice of wurtzite and zinc-blende phases exhibit a redshift of the photoluminescence spectra as low as 1.455 eV. The dimensions of the quantum heterostructures are correlated with the light emission, allowing us to determine the band alignment between these two crystalline phases. Our first-principles electronic structure calculations within density functional theory, employing a hybrid-exchange functional, predict band offsets and effective masses in good agreement with experimental results.

PACS numbers: 78.55.Cr,68.37.Og,61.72.Mm,78.67.Uh,71.15.Mb

I. INTRODUCTION

Semiconductor nanowires are attracting increasing interest because of their exciting optical and electronic properties and the possibility of synthesizing them in a controllable fashion¹⁻⁴. They are considered promising building blocks for the next generation of optical, sensing, electronic and energy harvesting devices⁵⁻⁸. Their small diameters, often at distances a few times the inter-atomic spacing in crystals, and their unique geometries lead to physical properties which differ significantly from the corresponding bulk material. Furthermore, nanowires hold the promise of integrating lattice-mismatched crystals on a single device, which opens new design possibilities and has the potential to significantly decrease production costs in solar cell applications⁹.

The functionality of nanowires is increased, and their properties are modified, when radial or axial heterostructures are created within a single wire ^{10,11}. Radial heterostructures can be produced by growing different materials on the side facets of the nanowires ^{12,13}, while axial heterostructures correspond generally to a variation in the chemical composition along the growth

axis^{2,4,14}. Recently, a second type of axial heterostructure has attracted attention, where the crystalline structure varies along the growth axis while the chemical composition is conserved. Typically, the structure is changed from the cubic zinc-blende to the hexagonal wurtzite structure^{15–17}. This change of crystalline structure has been observed in some bulk materials such as SiC and GaN^{18,19}. In phosphides and arsenides, it has been shown that the appearance of wurtzite phase is restricted to the nanowire form and is never observed in the bulk²⁰. The change in crystal structure is accompanied by changes in the electronic structure; for example, earlier theoretical work predicted a type II band alignment between the zinc-blende and wurtzite phases in III-V semiconductors²¹.

Recently, type II band alignment in InP nanowires^{22,23} has been demonstrated allowing the formation of crystal phase qantum dots²⁴. Meanwhile the band structure of wurtzite GaAs has been a subject of controversy in the last few years. Recent works on the luminescence of GaAs nanowires with a high percentage of wurtzite phase show a large variety of results. Recently luminescence of wurtzite GaAs in the range of 1.53-1.54 eV has been reported²⁵. Previously, Martelli et al. had reported an

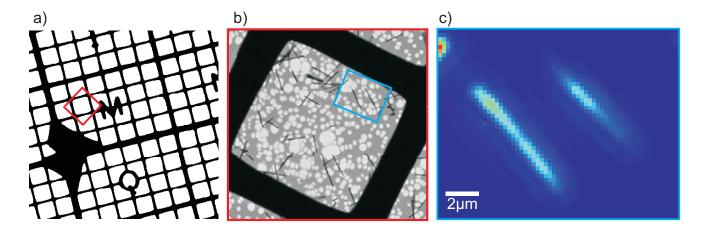


FIG. 1. Overview of the measurement process: a) Optical microscopy image of a TEM copper grid with marker symbols used for the studies. b) Detail of TEM grid showing the nanowires transferred to the holey carbon film. c) Color plot of integrated photoluminescence signal at 4.2 K from the area of the TEM grid marked by the blue box in b)

emission at 1.522 eV in wurtzite GaAs nanostructures²⁶. Meanwhile Moewe et al. reported an emission at 10 meV below the zinc-blende GaAs band gap²⁷. Additionally, our own results presenting a mixture of wurtzite and zinc-blende phases in nanowires are consistent with a type II band alignment and smaller band gap²⁸. Indeed in nanowires presenting 30% and 70% wurtzite phase we have observed extremely sharp peaks 1.43 and $1.515 \,\mathrm{eV}^{28}$. The spectra could be explained by the existence of quantum heterostructures forming a type II band alignment²⁸. Additionally similar results have been obtained by other groups²⁴. We believe that the apparent contradictions of some of these literature results can be related to the fact that the optical and structural characterizations were not performed on the same nanowire. This limits the possibilities to account for variability in the structure of different nanowires from one growth. In this work we will perform a direct correlation between the structural and optical properties in order to overcome this limitation.

To the best of our knowledge, a direct correlation between the optical properties and the structural sequence in the polytypism, which requires both functional and structural characterization on the same nanowire, has not yet been demonstrated²⁹. An initial effort in this direction was carried out by Bao $et\ al.^{22}$ who looked at the shift of the luminescence band as a function of the excitation power for highly twinned and twin-free zinc-blende structures in InP nanowires. Arbiol et al.³⁰ demonstrated by in-situ local electron energy loss spectroscopy (EELS) measurements on [111] zinc-blende inclusions in [0001] wurtzite nanowires in GaN the variation in the local density of states close to the band gap. Finally in different type of heterostructures, transmission electron microscopy (TEM) based cathodoluminescence was used to characterize GaN/InGaN/AlGaN nanowire heterostructures³¹. This technique enabled the direct correlation between the structural quality and and the carrier recombination characteristics in InGaN quantum wells³¹.

In this work, we provide a study that demonstrates direct correlation between the optical properties and structure at the atomic scale of GaAs nanowires formed by either pure wurtzite-GaAs or a combination of various thicknesses of the zinc-blende and wurtzite phases. This enables us to elucidate the band alignment between the two crystalline phases and represents an important step towards structural band gap engineering.

II. EXPERIMENTAL DETAILS

The nanowires were grown in a Gen II Molecular Beam Epitaxy (MBE) system. Wurtzite GaAs nanowires were grown by using gold as a catalyst, while the polytypic GaAs nanowires were obtained by the gold-free gallium-assisted growth method. In order to avoid crosscontamination because of the use of gold, the two different samples were fabricated in separate MBE systems. The nanowires with \sim 98-100% wurtzite GaAs were grown on GaAs (111)B substrates at a growth temperature of 540 °C under a As₄ Beam flux of $1.2 \cdot 10^{-6}$ mbar at a Ga rate equivalent to a planar growth of 0.8 Å/s. The growth time was 7500 s. The nucleation and growth followed the Vapor-Liquid-Solid mechanism, with Au as catalyst³². Details on the growth procedure are described in³³. After the axial growth of the nanowires the growth parameters were changed to conditions suitable for planar growth and the nanowires were passivated by an epitaxial prismatic shell of AlGaAs/GaAs material 12,13. The 2D equivalent amount grown during capping was 60 nm AlGaAs followed by 30 nm GaAs.

Wurtzite/zinc-blende polytypic nanowires were obtained on (1 $\overline{1}1$)B GaAs substrates previously coated with 20 nm SiO₂. The growth temperature was 630 °C and the As beam flux at the beginning of the growth pro-

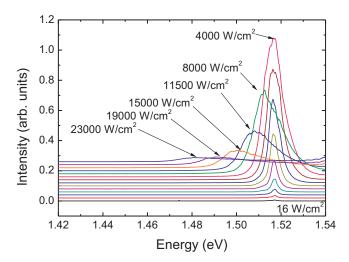


FIG. 2. Excitation power dependence of a typical capped zinc-blende GaAs nanowire, dispersed on a holey carbon film of a copper TEM grid. No pronounced heating effects are observed for excitation power densities up to $4000\,\mathrm{W/cm^2}$. For higher excitation powers the heating of the sample causes a change in band gap resulting in a redshift of the photoluminescence transition. For the highest excitation of $23000\,\mathrm{W/cm^2}$ the redshift corresponds to a temperature increase from $4.2\,\mathrm{K}$ to $140\,\mathrm{K}$. This clearly demonstrates that heating can be neglected for measurements performed at excitation powers in the order of $10\text{-}50\,\mathrm{W/cm^2}$.

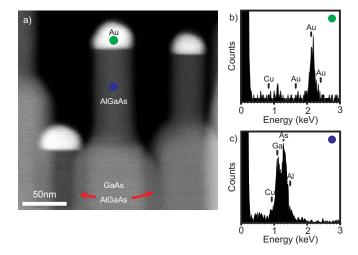


FIG. 3. a) Typical HAADF STEM micrograph obtained on a Au-seeded AlGaAs/GaAs NW. b) EDX spectrum taken at the tip of the nanowire confirming the presence of Au (Green). c) EDX spectrum at the neck of the nanowire confirming the presence of and AlGaAs on the neck (percentage of Al is low).

cess 8.8×10^{-7} mbar at a Ga rate equivalent to a planar growth of $0.22\,\text{Å/s}$. For this sample, the As beam flux increased slightly up to approx. 1×10^{-6} mbar during the growth. The nanowires were capped by an epitaxial shell of AlGaAs/GaAs^{12,13}.

For the direct correlation experiments, the nanowires were first transferred onto TEM holey carbon Cu grids.

The grids presented markers in order to facilitate the localization of the nanowires in the multiple measurements, see Fig. 1a-b. For the optical characterization, the grids were fixed freely suspended to a sample holder mounted in a confocal micro-photoluminescence (μ PL) setup. The sample stick was then immersed in a liquid helium bath cryostat. In order to ensure a good thermal dissipation during the optical measurements, the sample space was filled with a helium exchange gas at a pressure of ~ 5 mbar. The μPL measurements were carried out at a temperature of 4.2 K. The excitation sources were a semiconductor laser diode emitting at $780 \pm 10 \,\mathrm{nm}$ or a helium neon laser emitting at 632.8 nm. The laser was focused to a diffraction limited spot of about $0.8 \,\mu\mathrm{m}$ in diameter. This diffraction limit of light of the confocal microscopy is also the limiting factor for the overall resolution of the correlation technique. Typical excitation power densities were in the order of 10-50 W/cm², orders of magnitude below the level where significant heating of the sample could be observed (Fig. 2). Indeed, in contrast to similar experiments performed in a helium flow cryostat²², we did not observe any severe heating effects resulting from the low heat conductivity of the thin carbon membrane. In our case, we are able to realize μPL measurements on nanowires dispersed to a free-standing carbon membrane without the need of adding supplementary layers on top to allow for thermal dissipation as it was realized in previous studies²². Only this configuration enables simultaneous high resolution TEM and μ PL measurements on the same single nanowire. The position of the sample in the in the focal plane of the objective was verified by acquiring a confocal reflectivity image from the sample area. The μ PL measurements were then acquired by scanning an area of $20 \,\mu\text{m/side}$ with a step of 250 nm and aguiring a spectrum at each position, see Fig. 1c. The spatial dependence of PL spectra along the nanowire axis was obtained by plotting the suitable cross-section of this dataset.

Right after μ PL measurements the nanowires were studied by TEM. A series of connected bright field HRTEM micrographs was obtained from the bottom to the top of the nanowire, with the purpose of obtaining detailed information on the structure. Both high resolution and low resolution measurements were taken. The micrographs were taken along the nanowire, ensuring that the ends were overlapping with the previous/following micrographs. Multiple subsequent micrographs was necessary to map the whole length. The electron microscopy (TEM and HRTEM) measurements were carried out in a CM300 LaB6 microscope with a point to point resolution of 0.17 nm.

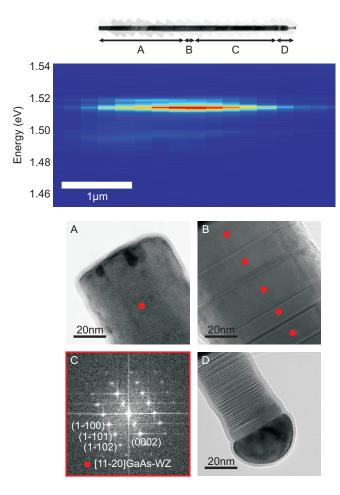


FIG. 4. Mapping of photoluminescence spectra along the length of the nanowire shown above. The scale bar applies to both the photoluminescence mapping and the TEM. A,B,D) HRTEM micrographs showing the crystalline phases at the regions of the nanowire indicated by the arrows above. Red dots mark wurtzite GaAs phase. C) Power spectrum of HRTEM micrograph in region C. Note that micrograph in region D corresponds to the axially grown AlGaAs/GaAs material during the radial capping forming a thin extension.

III. RESULTS

A. Wurtzite GaAs band gap

We start by presenting results in nanowires consisting of nearly 100% wurtzite. In this case, the direct correlation method is less important, as there is no significant variation on the structure along the nanowire. The correlation allows us to verify that the photoluminescence characteristics are correctly attributed to nanowires composed from wurtzite GaAs.

Fig. 3a shows a high angle annular dark field (HAADF) STEM micrograph of several nanowires from the sample. In principle the HAADF detector directly gives a contrast proportional to the atomic charge Z of the nuclei in the sample. The contrast also depends on the sam-

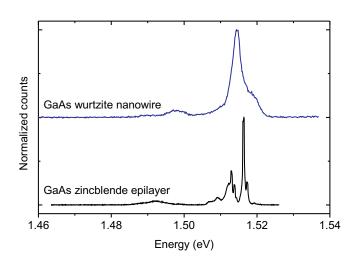
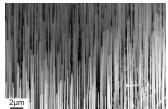


FIG. 5. Photoluminescence spectrum from nanowire consisting of pure wurtzite GaAs phase (top); Photoluminescence of a planar zinc-blende GaAs reference sample (bottom).

ple thickness that is not uniform in the axial extension compared to the rest of the wire. The image contrast in Fig. 3a therefore cannot directly indicate the chemical composition. For this reason energy dispersive X-ray spectroscopy (EDX) was performed at the thin extension and the catalyst droplet to clearly determine the chemical composition. Fig. 3b shows the EDX spectrum taken with the electron beam focused at the tip of the nanowire. The spectral features clearly demonstrate the presence of the Au catalyst. Meanwhile Fig. 3c shows that the thin extension of the nanowire towards the tip corresponds to axially grown AlGaAs. This is in clear agreement with the picture that during the radial capping with the Al-GaAs/GaAs shell the nanowire continues to grow axially from precipitation below the catalyst droplet. Indeed for the case of Au catalyzed nanowire the metallic catalyst is not affected by the growth conditions. We can therefore use the size of the nanowire neck to accurately estimate the size of the nanowire core.

Now we turn to the correlation between HRTEM and spatial dependent PL. In Fig. 4 we have included TEM micrographs representative of various locations along the nanowire. As shown at the left end the nanowire consists of pure wurtzite GaAs free of stacking faults throughout a 1.2 μ m long region A (Fig. 4). In the 150 nm long region B we can observe seven stacking faults in the nanowire that is otherwise still composed of pure wurtzite phase. The following 1 μ m of the nanowire (C) are stacking-fault free wurtzite GaAs material. The final 250 nm (D) of the nanowire exhibits a mixture of heavily twinned zincblende and wurtzite phases. This can be attributed to the stage in which the conditions (mainly As pressure) were changed from axial to predominantly radial growth. Region D corresponds to the remaining axial growth occurring during the capping and is composed of AlGaAs as discussed before. Fig. 5 shows the typical PL spectra



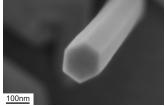


FIG. 6. Scanning electron micrographs of the as-grown nanowire sample grown with the Ga assisted growth mechanism. The nanowires grow perpendicular to the $(1\overline{1}1)B$ substrate surface.

along the approximately $2.8\,\mu\mathrm{m}$ long nanowire. An emission peak at approx. $1.515\,\mathrm{eV}$ is observed throughout the length of the nanowire. By exciting the luminescence with an HeNe laser with a photon energy of $1.96\,\mathrm{eV}$, we have verified that there is no emission in the range of energies between 1.52 and $1.63\,\mathrm{eV}$. This is in agreement with our previous studies in which the luminescence in wurtzite/zinc-blende heterostructured nanowires was always observed below $1.515\,\mathrm{eV^{28}}$. Furthermore this value is in agreement with recent theoretical predictions³⁴.

We have examined at least 4 nanowires with the same structural characteristics (nearly 100% wurtzite) and we did not observe any luminescence at the energies between 1.52 and 1.63 eV . Additionally, in order to rule out possible contamination of the nanowires, we have measured the PL of a 1 $\mu \rm m$ thick GaAs epilayer. The spectrum is shown in Fig. 5 The emission is peaked at 1.516 eV, as expected for excitonic transitions in high purity GaAs. The additional sharp peaks in the PL spectrum as well as the broad emission at 1.49 eV can be attributed to carbon impurities. As a consequence we can conclude that our measurements are consistent with an interband transition in the wurtzite GaAs at 1.515 eV clearly originated in the core of the nanowire.

Finally, we want to further discuss the relation between the observed emission at 1.515 eV and the band gap of bulk wurtzite GaAs. The diameter of the catalyst droplet and therefore the nanowire core is approx. 33 nm (see Fig. 4D). Due to the small size, the radial confinement of carriers is causing a slight blue shift with respect to the actual bulk band gap. We have estimated this confinement energy by simulating 35 this structure with nextnano 3. For simplicity the calculations are using the zinc-blende GaAs band parameters. The simulations show a confinement energy in the range of 13.5-17.8 meV for diameters between 35-30 nm. By correcting the observed emission energy with the estimated radial confinement energy we obtain an estimated wurtzite GaAs band gap of 1.50 eV.

B. Wurtzite/zinc-blende GaAs band offsets

We now turn to the central aspect of this work, which is the correlation between the structural and optical properties in wurtzite/zinc-blende heterostructures. Representative SEM micrography of the as-grown Ga catalyzed sample is shown in Fig. 6. The gallium droplet at the top of the nanowire disappeared during the growth of the shell.

Fig. 7a shows the μ PL spatial dependence in a 7 μ m long nanowire with a diameter of 170 nm. Below the PL scan we have included TEM micrographs representative of various locations on the nanowire. From the structural point of view the nanowire is composed of two regions: (i) one with zinc-blende and a variation in twin density. (ii) one with a mixture of zinc-blende and wurtzite phases similar to a slightly disordered superlattice. The left side of the figure corresponds to the tip of the nanowire, which is in the zinc-blende phase with rotational twins separated by ~ 100 nm, shown in Fig. 7b. From left to right (towards the base of the nanowire), the density of deviations from an ideal zinc-blende crystal structure increases in a regular way.

Within $6\,\mu\mathrm{m}$ from the left end of the nanowire these deviations are predominantly rotational twins and can be described considering a gradually increasing statistical twin density. For example, at positions $1\,\mu\mathrm{m}$, $3\,\mu\mathrm{m}$ and $5\,\mu\mathrm{m}$, we observe a twin density of 60, 223 and 479 twins/ $\mu\mathrm{m}$, respectively, shown in Fig. 7c-d. This increase in the twin density is accompanied by a regular red-shift of the PL peak from 1.50 to 1.48 eV. The PL signal is spatially discontinuous.

In the final third of the nanowire the concept of twin density is not sufficient to describe the structure of the nanowire, as segments of wurtzite phase appear regularly. We can describe considering the fraction of wurtzite phase present in the nanowire. At a distance of $6 \,\mu \mathrm{m}$ from the tip, the highly dense twin lattice turns into an alternation of 2 to 5 nm thick zinc-blende and wurtzite sections. At that point, the percentage of wurtzite is $\approx 50\%$ and the average spacing of each of the phases $\approx 2 \,\mathrm{nm}$ (Fig. 7e). Moving forward towards the right, the percentage of wurtzite quickly increases up to 100%, approximately 400 nm before the bottom of the nanowire. Some stacking faults and inclusions of zinc-blende smaller than 1 nm are observed right at the base, as shown in Fig. 7f. A continuous wurtzite region of 290 nm is also found, shown in Fig. 7g. This region is followed by a single 2.4 nm insertion of zinc-blende followed by 84 nm of wurtzite. Exactly at the base, we find a 46 nm thick section with a mixture of wurtzite and zinc-blende. The gradual decrease of wurtzite fraction and twins is related to the increase in As₄ pressure during the growth²⁸.

Interestingly, for the nanowire section where the twin density increases, the PL shifts from 1.51 down to 1.48 eV. After this, consistent with the regions where wurtzite sections appear clearly, the PL peak shifts further down to 1.46 eV. At the final section of the nanowire a blue-shift of the PL energy is observed. We never observe PL signal above 1.515 eV. A total of four nanowires were investigated with the direct correlation method. They all showed a similar behavior. Another example

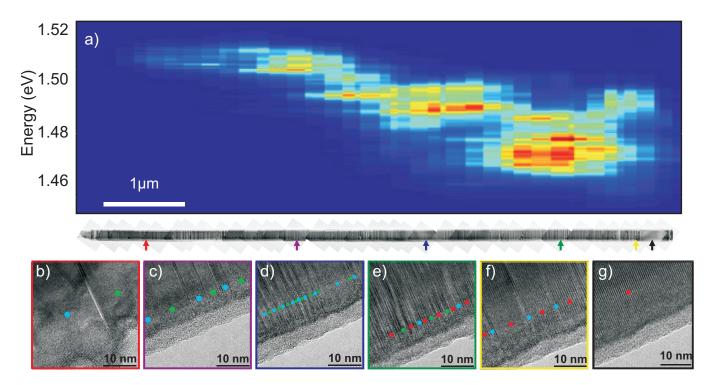


FIG. 7. a) Mapping of photoluminescence spectra along the length of the GaAs wurtzite/zinc-blende heterostructure nanowire shown below. The scale bar applies to both the photoluminescence mapping and the TEM. b-g) HRTEM micrographs showing the crystalline phases at the positions of the nanowire indicated by the respectively colored arrows. Red dots mark the wurtzite phase while blue and green dots show the zinc-blende phase.

is shown in Fig. 8a.

The measurements presented above raise two main questions:

- 1) In the top two thirds of the nanowire, why is the twinning density shifting the PL emission towards lower energies from 1.51 to 1.48 eV?
- 2) Can one derive the values of the conduction and valence band discontinuity between wurtzite and zincblende from the correspondence between the TEM and PL measurements?

In order to address the first question, we start by analyzing what seems to be a twin density dependence of the PL emission. Indeed, we have observed a significant red-shift (40 meV) for a twin density varying from 50 to 500 twins/ μ m. Various causes may be responsible for this. For example, it is known that the binding energy of excitons confined in quantum well-like structures increases³⁶. However in GaAs, even in the ideal 2D confinement limit, this could not account for a shift of more than $\sim 12 \,\mathrm{meV}$ at most³⁶. It is known that a change of effective mass within the quantum well plane could further increase the exciton binding energies²⁹. However the in-plane effective masses are not expected to change so significantly in wurtzite GaAs³⁴. Most importantly, the presumably type II nature of the transition actually leads to a separation of electrons and holes thus diminishing the Coulomb interaction between the carriers. Moreover, a type II superlattice of single wurtzite layers in zincblende with varying superlattice periodicity cannot be an explanation because it would lead to a blue shift instead of a red shift. Finally, we must consider the possible correlation between the twin density and the appearance of single structures with several consecutive twins, corresponding to thin sections of the wurtzite phase. The occurrence of one twin is often illustrated as one monolayer of wurtzite. Multiple consecutive twinning leads to the formation of thicker wurtzite segments, which could account for the PL peaks below the GaAs band gap.

For a relatively homogeneous twin density over a length of several hundreds of nm, the twin density in that region gives directly the probability p for a twinning event to occur during nucleation of a GaAs atomic layer in the (111) direction:

$$p = \frac{a\rho}{\sqrt{3}} \tag{1}$$

where a is the cubic GaAs lattice constant and ρ is the density of twins in the region of the nanowire. Assuming statistical independence of the twinning process³⁷ and the law of large numbers the probability of n subsequent twinning events to occur is given by $p_n = p^n(1-p)$. We can therefore derive the average distance between such occasional segments consisting of n consecutive twins.

$$d_n = \frac{a}{\sqrt{3}p_n} \tag{2}$$

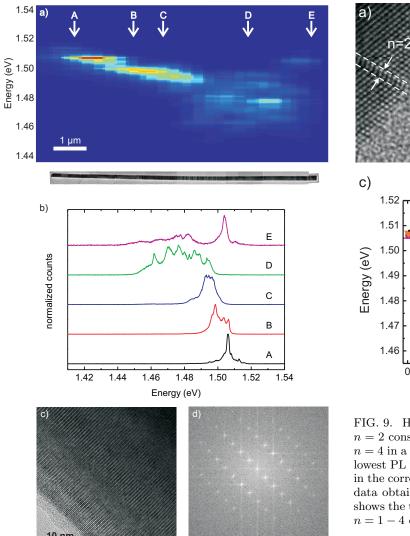


FIG. 8. a) Photoluminescence mapping and TEM reconstruction of another wurtzite/zinc-blende heterostructure GaAs nanowire from the sample. The scale bar applies to both the photoluminescence mapping and the TEM. b) Individual photoluminescence spectra of the five positions marked in a). All spectra are normalized in intensity. c) HRTEM micrograph of region E of the nanowire. d) Powerspectrum of micrograph c)

In order to reveal the existence of multiple twinning and formation of thin segments of wurtzite, we examined each of the HRTEM micrographs along the nanowire. We found sections formed by 2-5 monolayers (ML) of wurtzite in regions with increasing twin density. HRTEM micrographs corresponding to n=2 and n=4 are shown in Fig. 9a-b. The position of these sections corresponds to regions in the nanowire with high PL intensity. In Fig. 9c we plot the PL peak position as a function of the twin density of the nanowire section. Low temperature PL is very sensitive to the presence of such inhomogeneities with lower recombination energies. The majority of pho-

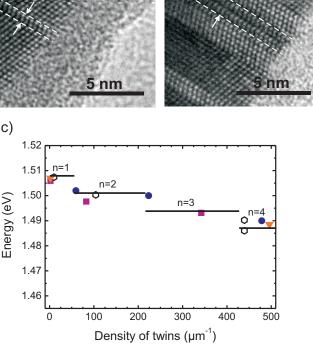


FIG. 9. HRTEM micrographs showing the occurrence of: a) n=2 consecutive twins in a region with <85 twins/ μ m; b) n=4 in a region with >400 twins/ μ m. c) Correlation of the lowest PL transition energy to the density of rotational twins in the corresponding part of the nanowire. The symbols show data obtained from four different nanowires. The black line shows the transition energies for wurtzite segments formed by n=1-4 consecutive twins.

togenerated carriers diffuse to the wurtzite quantum wells (lower energy) where they recombine. The line widths of the peaks are extremely sharp with a FWHM below $2.5~{\rm meV}$, which further corroborates our explanation (Fig. 8b). We also plot the position of the peaks observed in positions where twin stacks with n between 1 and 4 are observed by HRTEM. Clearly, the redshift in the PL peaks is correlated with the existence of consecutive twins and the existence of 1, 2 and 3 ML thick single wurtzite regions.

In the last third of the nanowire, segments of wurtzite appear regularly, as shown in Fig. 7e. In the PL mapping, multiple peaks are observed from 1.49 down to 1.455 eV. The final part on the right end of the nanowire is composed of pure wurtzite GaAs material segments with a length of up to 290 nm, see Fig. 7f-g, with small insertions of the zinc-blende structure. This region shows again PL emission above 1.49 eV. In order to address the question of whether the band offsets between wurtzite and zinc-blende GaAs phases can be determined, we plot the PL peaks as a function of the wurtzite phase fraction γ in Fig. 10. The horizontal error bars represent the micro-

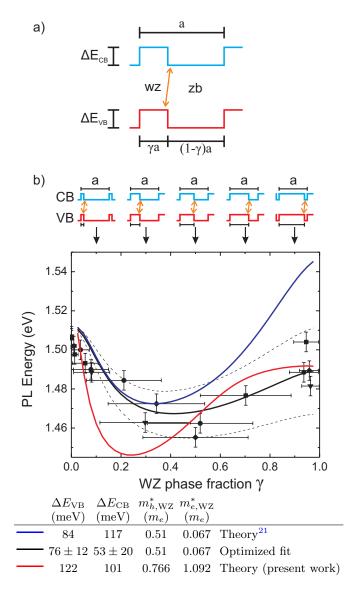


FIG. 10. a) Schematic of the type II homogeneous superlattice model with wurtzite phase fraction γ and periodicity $a=13\,\mathrm{nm}$. b) Lowest PL transition energy as a function of the fraction of wurtzite phase γ in the corresponding part of the nanowire (symbols). The colored lines show results from model calculations. The dashed black lines give the prediction bounds of the model fit to the experimental data.

scopic variations of the actual nonperiodic heterostructure from an ideal homogeneous superlattice. Peaks at 1.455 eV correspond to regions of the nanowire exhibiting approximately 50:50 composition of the wurtzite and zinc-blende phases. Peaks at energies higher than 1.455 eV correspond to sections in the nanowire richer in one of the two phases. We point out that the highest energy PL peaks in the region with pure wurtzite correspond to a band gap of 1.504 eV; we never observed PL at energies above the free exciton of zinc-blende GaAs.

Finally, we propose a model to explain the PL emission in the last third of the nanowire. To this end, we calculate the miniband formation of a homogeneous superlat-

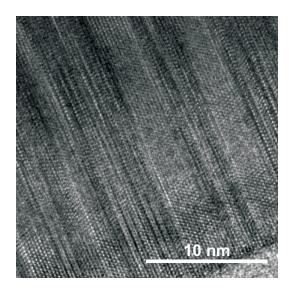


FIG. 11. HRTEM micrograph of the largest segment of the nanowire with regions composed of equal fractions of the zinc-blende and wurtzite phases, each approx. 6.5 nm in length along the nanowire axis.

tice (SL) with type II band alignment and band offsets $\Delta E_{\rm CB}$ and $\Delta E_{\rm VB}$, shown in Fig. 10a, using a Kronig-Penney model. The overall lattice periodicity was set to $a_{\rm SL} = 13 \, \rm nm$ which is the widest periodicity observed by TEM in the region of 50:50 phase composition, see Fig. 11. The largest periodicities in the structure correspond to the lowest recombination energies. Low temperature microphotoluminescence is most sensitive to the transitions with the lowest recombination energies. The calculations were performed for various valence and conduction band offsets and are plotted in Fig. 10b varying the relative thickness of the wurtzite and zinc-blende segments in the superlattice and considering the experimental band gap of zinc-blende GaAs in all cases. We want to note that the calculations are neglecting modifications of the band structure from strain³⁸ and spontaneous polarization of the hexagonal phase³⁹. As a first attempt to provide a quantitative explanation, we use the values $\Delta E_{\mathrm{CB}} = 117\,\mathrm{meV}$ and $\Delta E_{\mathrm{VB}} = 84\,\mathrm{meV}$ obtained in earlier theoretical work²¹, and effective masses in wurtzite GaAs identical to the experimental ones for zinc-blende GaAs. The result is shown in Fig. 10b. Clearly, there is a disagreement between the theory and the experimental data for sections of the nanowire with a large wurtzite content. By least square fitting of the experimental data with the periodic superlattice model we can estimate $\Delta E_{\rm CB} = 53 \pm 20 \,\mathrm{meV}$ and $\Delta E_{\rm VB} = 76 \pm 12 \,\mathrm{meV}$.

C. Calculation of the band offset and effective masses

In order to obtain more accurate band offsets and effective mass values, we performed electronic structure

TABLE I. The calculated energy band gaps and band offsets: LDA and HSE06 refer to the present work (see text for details). For comparison we also include the results of earlier work using ab initio calculations 21,40,41 or an Empirical Pseudopotential method 34 . Experimental results for band offsets are from the optimal fit shown in Fig. 10. $\varepsilon_{\rm gap-ZB}$ is the band gap of zinc-blende phase while $\Delta\varepsilon_{\rm gap} = \varepsilon_{\rm gap-WZ} - \varepsilon_{\rm gap-ZB}$ corresponds to the difference in band gap between the zinc-blende and wurtzite phases.

	$\varepsilon_{\mathrm{gap-ZB}} \; (\mathrm{eV})$	$\Delta \varepsilon_{\mathrm{gap}} \ (\mathrm{eV})$	$\Delta E_{\mathrm{VB}} \; (\mathrm{meV})$	$\Delta E_{\mathrm{CB}} \; (\mathrm{meV})$
DFT-LDA ²¹	0.614	+0.033	84	117
DFT-LDA ⁴⁰	0.44	+0.03	-	-
$DFT-GW^{41}$	1.133	+0.218	-	-
EP^{34}	1.519^{a}	-0.016	79.2	63.2
DFT-LDA	0.351	-0.044	114	70
DFT-HSE06	1.405	-0.021	122	101
experiment	1.51	-0.023	76 ± 12	53 ± 20

^a Based on fit to experimental zinc-blende band gap

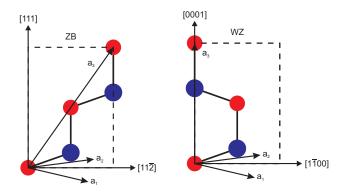


FIG. 12. The structures used in the calculations for the zinc-blende and wurtzite lattices, with lattice vectors $\mathbf{a}_1, \mathbf{a}_2, \mathbf{a}_3$. The larger (blue) and smaller (red) circles denote the two types of ions and the [111] and [11 $\overline{2}$] crystallographic directions in zinc-blende, as well as the [0001] and [1 $\overline{1}$ 00] crystallographic direction in wurtzite are indicated.

calculations in the context of Density Functional Theory (DFT)⁴² using VASP⁴³. For the full band-structure throughout the Brillouin Zone (BZ), we employed the standard Local Density Approximation (LDA) 44,45, with corresponding pseudopotentials. It is well known that this type of approach does not reproduce well the unoccupied part of the electronic spectrum and the energy band gap. Recently, it was shown that both the band gap⁴⁶ and the excitation energies⁴⁷ are vastly improved by applying a screened Hartree-Fock hybrid exchange functional (HSE06)^{48,49}. However, such calculations due to their high computational cost can be performed only for selected high-symmetry points in the BZ. Our approach then consists of performing a full band-structure calculation with the LDA method and using the HSE06 results to correct the excited states, by applying a uniform shift equal to the band gap correction for the zincblende structure; we are fully aware that such a "scissor operator" approach may not be adequate⁵⁰, but for the

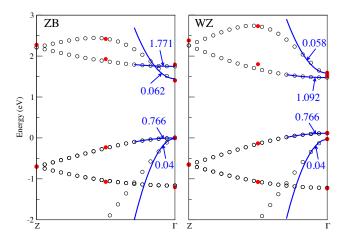


FIG. 13. The band structures of the zinc-blende and wurtzite lattices along the Z Γ direction in the Brillouin Zone. Open black circles are the results of the LDA calculations, red filled circles are the results of HSE06 calculations and blue lines are quadratic fits near Γ . The values in blue indicate the effective masses in units of m_e obtained from the quadratic fits.

bands of interest this approach gives very good results as explained below. For the hybrid exchange calculations we employed the PBE exchange-correlation functional in the DFT part 51 and PAW potentials to represent the ions 52 . We use a unit cell that has the same number of atoms in the zinc-blende and wurtzite lattices, by doubling one of the lattice vectors of the former, as shown in Fig. 12. We used plane-wave energy cutoffs of 326 eV for the LDA and 400 eV for the HSE06 calculations, and a reciprocal space Monkhorst-Pack grid of $8\times8\times4$ k-points 53 . We used the experimental in-plane lattice constant of zinc-blende (3.99 Å) corresponding to bulk a=5.65 Å. This is very close to the calculated ones, (3.95 Å) for both the zinc-blende and wurtzite phases. For this we neglected the effect of strain and influence of band structure.

The results of the calculations are collected in Ta-

ble I and the band structures for the zinc-blende and wurtzite phases are shown in Fig. 13, along the important directions, that is, [111] for zinc-blende and [0001] for wurtzite. We can calculate the band structure of this interface and assign each band to relevant wurtzite or zinc-blende phase, based on density distribution and similarity to bands of the bulk zinc-blende and wurtzite structure. In this way we can get information of band alignment/offsets of this interface. It is clear from the plot in Fig. 13 that along these directions in reciprocal space the uniform shift of excited LDA states (open black circles) by an amount equal to the band gap correction for the zinc-blende phase, brings them to excellent agreement with the calculated HSE06 results (filled red circles). The calculated band offsets are $\Delta E_{\rm CB} = 101 \, {\rm meV}$ and $\Delta E_{\rm VB} = 122 \, {\rm meV}$, and effective masses along the [0001] wurtzite orientation are $m_{h,WZ}^* = 0.766 m_e$ and $m_{e,WZ}^* = 1.092 m_e$; the corresponding values for the [111] zinc-blende orientation are $m_{h,\text{ZB}}^* = 0.766 \ m_e$ and $m_{e,ZB}^* = 0.062 m_e$. The essential difference is in the electron effective mass, which comes from the folding of the bands along the [0001] wurtzite orientation, as seen in Fig. 13. The corresponding superlattice model curve using the calculated band offsets and wurtzite effective masses is shown in Fig. 10b. Our first principles calculations indicate that the band gap of wurtzite GaAs is 21 meV lower compared to the band gap of the zincblende phase are in good agreement with the experimental data. Our experimentally determined band offsets are also in excellent agreement with band offsets recently calculated by De and Pryor³⁴ using an Empirical Pseudopotential method (see Table I).

IV. CONCLUSIONS

In conclusion, we have presented results on a new technique that enables the experimental direct correlation between confocal micro-photoluminescence measurements and the structural characterization with high resolution transmission electron microscopy of nanowires consisting of nearly 100% wurtzite and presenting wurtzite/zinc-blende polytypism. The observations are in good agreement with theoretical predictions for the band gap and band offsets between the wurtzite and zinc-blende phases of GaAs. In wurtzite GaAs nanowires, we observe photoluminescence always below 1.52 eV. Taking into account the electronic confinement, the results indicate that the electronic band gap of wurtzite GaAs phase is slightly smaller than zinc-blende GaAs with an estimated

 $\varepsilon_{\rm gap-WZ} = 1.50 \, \rm eV.$

The results on the polytypic nanowires are multiple. First, we correlate the appearance of wurtzite sections with the probability of twin formation. Then, we link the position of the luminescence with the stacking sequence of the wurtzite and zinc-blende phases. Due to the fact that the actual nanowire heterostructure is non periodic, an exact calculation for the optical transitions would require a model including the complete stacking sequence of each nanowire with atomic precision; it is extremely challenging to determine this sequence experimentally. Using a more simple periodic superlattice model, we have demonstrated that the experimental findings can be well explained despite the drastic simplifications of the model; we determine for the first time an experimental estimation for the band offsets of $\Delta E_{\rm CB} = 53 \pm 20 \, {\rm meV}$ and $\Delta E_{\rm VB} = 76 \pm 12 \, {\rm meV}$. These band offsets correspond to a band gap for wurtzite GaAs of approx. 23 meV lower compared to the band gap of the zinc-blende phase. This is in excellent agreement with our results on pure wurtzite GaAs nanowires, other experiments²⁷, our first principles calculations and other recent band structure calculations³⁴. Furthermore, a slightly smaller band gap of the wurtzite phase of GaAs is supported by our general observation that even though both nanowire samples contain large amounts of wurtzite GaAs, we have never observed PL emission above the band gap of zinc-blende GaAs.

ACKNOWLEDGMENTS

The authors thank G. Abstreiter, T. Garma, D. Spirkoska and M. Bichler for their experimental support and discussions. We thank A. Petroutchik and L. T. Baczewski for the preparation of the Au-covered substrates for NW growth. This research was supported by Marie Curie Excellence Grant 'SENFED', the DFG excellence cluster Nanosystems Initiative Munich, as well as SFB 631 and ERC Starting Grant 'Upcon'. This work was partially supported by the Spanish Government projects Consolider Ingenio 2010 CSD2009 00013 IMAG-INE and CSD2009 00050 MULTICAT. J.A. acknowledge the funding from the Spanish CSIC project NEAMAN and MICINN project MAT2010-15138 (COPEON). The authors would like to thank the TEM facilities in the Interdisciplinary Center for Electron Microscopy in Lausanne and in Barcelona. E.R. acknowledge financial support from the ERA Nanoscience Project 'QOptInt'. E.R. and D.S. thank for support via SFB 689.

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